

BCT4567A

Low-Power, Dual SIM Card Analog Switch

GENERAL DESCRIPTION

The BCT4567A is a QPDT switch with one common control inputs targeted at dual SIM card multiplexing. It is optimized for switching the WLAN-SIM data and control signals and dedicates one channel as a supply-source switch.

The BCT4567A is compatible with the requirements of SIM cards and feature a low on capacitance to ensure high speed data transfer, the VSIM switch path has a low RON characteristic to ensure minimal voltage drop in dual SIM card supply paths.

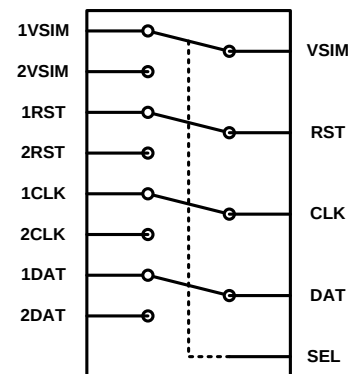
The device operates from a +1.65V to +5.0V supply and over the extended -40°C to +85°C temperature range. It is offered in 16-pin 3mm x 3mm TQFN package or 16-pin 2.6mm x 1.8mm QFN package.

APPLICATIONS

Dual SIM Card Switch
Cell Phones
Pad
Digital Cameras
PDAs
Notebook

FEATURES

- Wide VCC Operating Range: 1.65 V to 5.0V
- Low On-Resistance
Supply Path: 0.7Ω @VCC=2.7V
Data Path: 3.3Ω @VCC=2.7V
- Low Power supply current: 1uA(MAX)
- Rail-to-Rail Signal Switching Range
- Fast Switching Speed: 20ns@VCC=3.3V
- Data Path -3dB bandwidth: 260MHz
- High Off Isolation: -68dB
- Crosstalk Rejection: -76dB
- Space-Saving, TQFN 3x3-16L or QFN 2.6x1.8-16L Package



LOGIC DIAGRAM

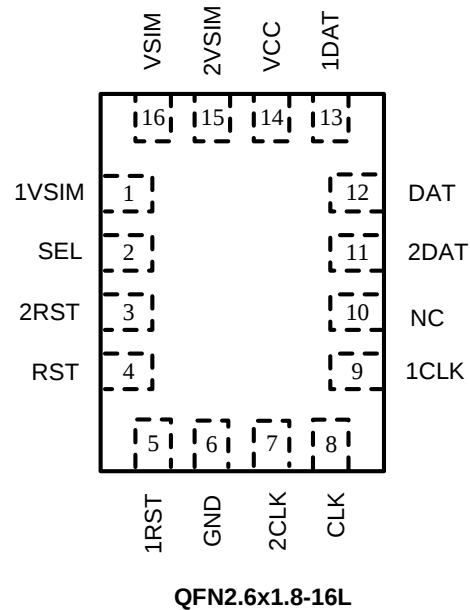
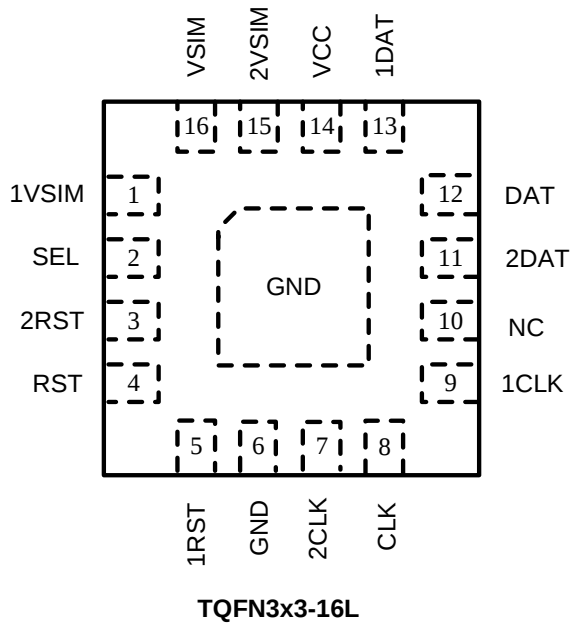
ORDERING INFORMATION

Ordering Code	Package Description	Temp Range	Top Marking	QTY/Reel
BCT4567AEGE-TR	TQFN3x3-16L	-40°C to +85°C	 4567A XXXXXX	3000
BCT4567AEFE-TR	QFN2.6x1.8-16L	-40°C to +85°C	4567A XXXXXX	3000

Mark Note:

1. "4567A" in Marking is Product code
2. "XXXXXX" in Marking will be appeared as the batch code.

Pin Configurations



Pin Description

Pin	Name	Function
1	1VSIM	SIM supply output 1
2	SEL	Select input
3	2RST	RST Normally Open Terminal
4	RST	RST Common Terminal
5	1RST	RST Normally Closed Terminal
6	GND	Ground
7	2CLK	CLK Normally Open Terminal
8	CLK	CLK Common Terminal
9	1CLK	CLK Normally Closed Terminal
10	NC	Not Connect
11	2DAT	DAT Normally Open Terminal
12	DAT	DAT Common Terminal
13	1DAT	DAT Normally Closed Terminal
14	VCC	Power Supply
15	2VSIM	SIM supply output 2
16	VSIM	SIM supply input

Truth Table

SEL	SWITCH STATE
0	1DAT = DAT, 1RST = RST, 1CLK = CLK, 1VSIM = VSIM
1	2DAT = DAT, 2RST = RST, 2CLK = CLK, 2 VSIM = VSIM

Absolute Maximum Ratings

VCC, SEL to GND.....	-0.3V to +6.0V
All Other Pins to GND.....	-0.3V to (VCC + 0.3V)
SUPPLY SWITCH Continuous Current.....	±400mA
SUPPLY SWITCH Peak Current (pulsed at 1ms, 10% duty cycle)	±500mA
DATA SWITCH Continuous Current	±100mA
DATA SWITCH Peak Current (pulsed at 1ms, 10% duty cycle)	±120mA
Continuous Power Dissipation (TA = +70°C)	
TQFN3x3-16L (15.6mW/°C)	1.25W
QFN 2.6x1.8-16L (8.5mW/°C)	0.68W
Operating Temperature Range	-40°C to +85°C
Storage Temperature Range.....	-65°C to +150°C
Junction Temperature.....	+150°C
Lead Temperature (soldering, 10s)	+260°C
ESD HBM (human body model)	4KV

NOTE:

Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Electrical Characteristics

(unless otherwise noted. Typical values are at $V_{CC} = 3.3V$, $T_A = +25^{\circ}C$.) (2)

Parameter	Symbol	Conditions		Min	Typ	Max	Units
POWER SUPPLY							
Supply Voltage Range	VCC			1.65		5.0	V
Supply Current	ICC	VCNTRL = 0 or VCC, IOUT = 0				1	uA
ANALOG SWITCH							
Analog Signal Range	VSW	Switch I/O Voltage		0		VCC	V
VSIM On-Resistance	RON	ION = -100 mA Figure 9	VCC= 1.8V VSW = 0, 1.8 V		0.8		Ω
			VCC= 2.7V VSW = 0, 2.3 V		0.7		
CLK, RST, DAT, On-Resistance	RON	ION = -20 mA Figure 9	VCC= 1.8V VSW = 0, 1.8 V		4.0		Ω
			VCC= 2.7V VSW = 0, 2.3 V		3.3		
CLK, RST, DAT, On-Resistance Match	ΔRON	ION = -20 mA Figure 9	VCC= 2.7V VSW = 0, 2.3 V		0.3		Ω
CLK, RST, DAT, On-Resistance Flatness	RFLAT	ION = -20 mA Figure 9	VCC= 2.7V VSW = 0V to VCC		1.0		Ω
Off-Leakage Current	IOFF	VCC= 5.0V, nRST, nDAT, nCLK, nVSIM = 0 V to 5.0 V Figure 10		-1		1	uA
On-Leakage Current	ION	VCC= 5.0V, RST, DAT, CLK, VSIM = 0 V to 5.0 V		-1		1	uA
SEL DIGITAL INPUTS							
Input-Logic High	VIH	VCC=1.65V to 5.0V		1.7			V
Input-Logic Low	VIL	VCC=1.65V to 5.0V				0.4	V
Input Leakage Current	IIN	VIN = 0 or VCC		-1		1	uA

Electrical Characteristics (continued)

(unless otherwise noted. Typical values are at $V_{CC} = 3.3V$, $T_A = +25^\circ C$.) (2)

Parameter	Symbol	Conditions	Min	Typ	Max	Units	
DYNAMIC CHARACTERISTICS							
Turn-On Time Sel to Output (DAT,CLK,RST)	T _{ON}	R _L = 50 Ω, C _L = 35 Pf, V _{SW} = 1.5 V, Figure 11, Figure 12	T _A = +25°C		20	30	ns
			T _A = T _{MIN} to T _{MAX}			50	
Turn-Off Time Sel to Output (DAT,CLK,RST)	T _{OFF}	R _L = 50 Ω, C _L = 35 pF, V _{SW} = 1.5 V, Figure 11, Figure 12	T _A = +25°C		15	40	ns
			T _A = T _{MIN} to T _{MAX}			50	
Break-Before-Make Time (DAT,CLK,RST)	t _{BBM}	R _L = 50 Ω, C _L = 35 pF V _{SW1} = V _{SW2} = 1.5 V Figure 15	T _A = +25°C	2	15		ns
			T _A = T _{MIN} to T _{MAX}	2			
Charge Injection	Q	C _L = 50 pF, R _{GEN} = 0 Ω, V _{GEN} = 0 V			100		pC
On-Channel Bandwidth -3dB (DAT,CLK,RST)	BW	R _L = 50 Ω, C _L = 5 pF Figure 16			260		MHz
Off-Isolation (DAT,CLK,RST)	V _{ISO}	R _L = 50 Ω, f = 1MHz Figure 17			-68		dB
Crosstalk	V _{CT}	R _L = 50 Ω, f = 1MHz Figure 18			-76		dB
RST, CLK, DAT Off Capacitance	C _{OFF}	V _{CC} = 3.3 V, Figure 19			7		pF
RST, CLK, DAT On Capacitance	C _{ON}	V _{CC} = 3.3 V, f = 1 MHz Figure 20			20		pF

Note 2: Devices are 100% tested at $T_A = +25^\circ C$. Limits across the full temperature range are guaranteed by design and correlation.

Test Diagrams /Timing Diagrams

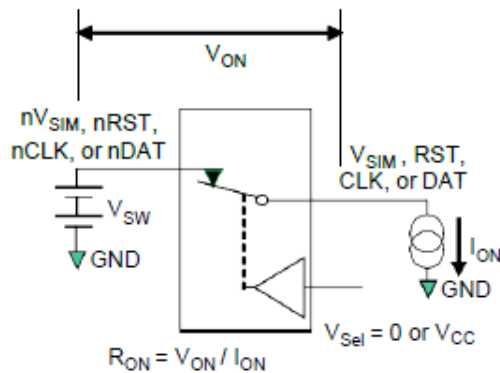


Figure 9. On Resistance

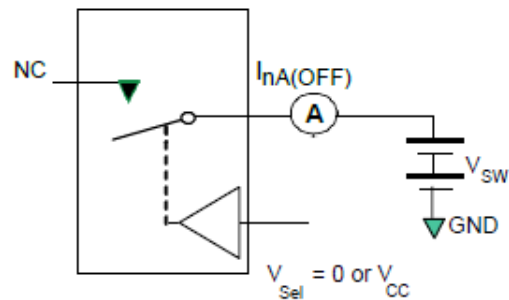


Figure 10. Off Leakage

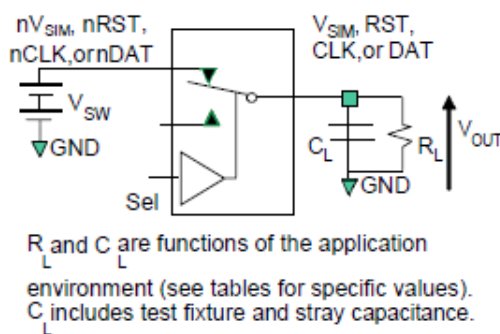


Figure 11. AC Test Circuit Load

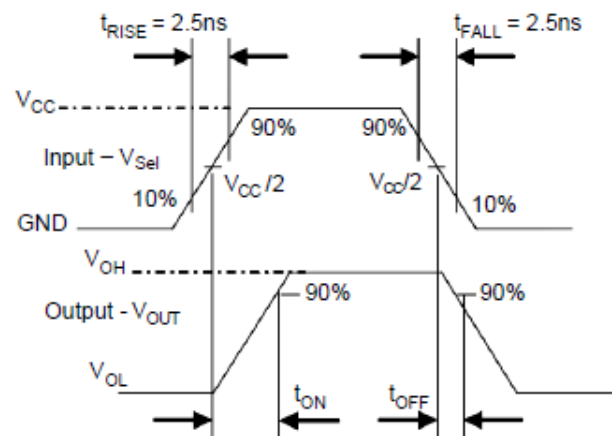


Figure 12. Turn-On / Turn-Off Waveforms

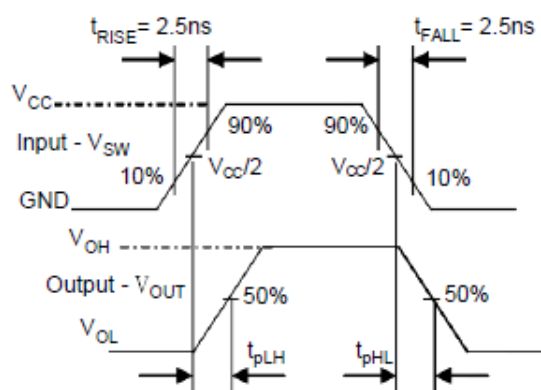


Figure 13. Propagation Delay

Test Diagrams /Timing Diagrams

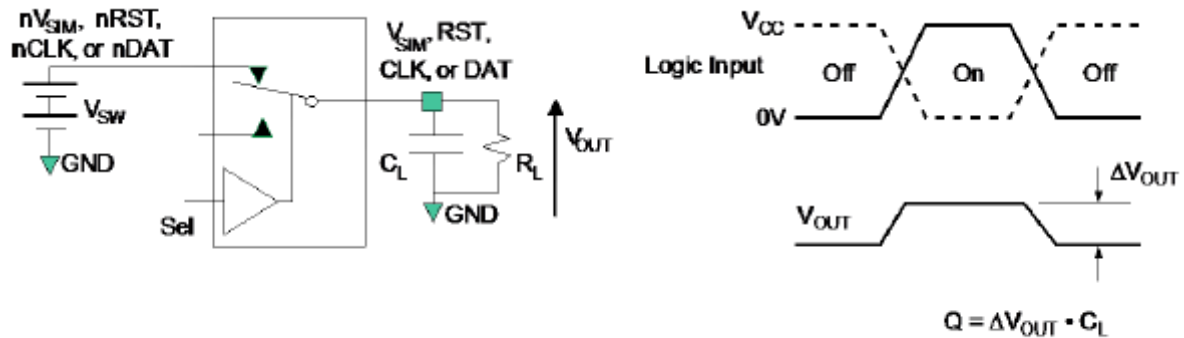


Figure 14. Charge Injection

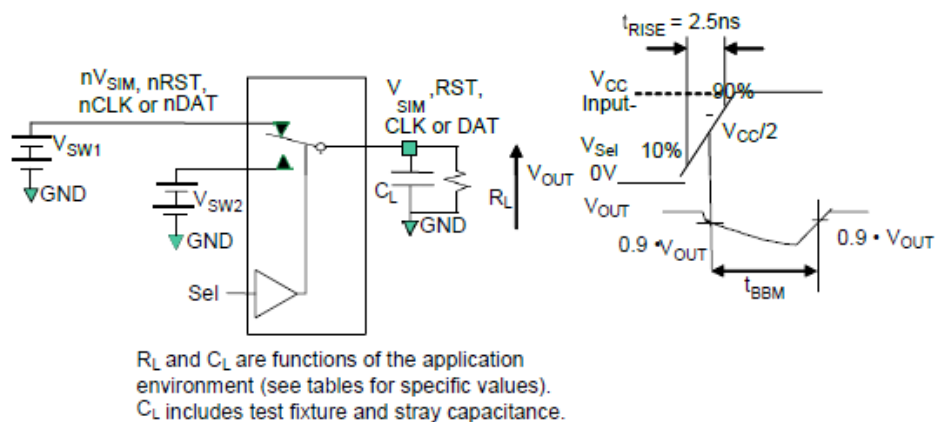


Figure 15. Break-Before-Make Interval Timing

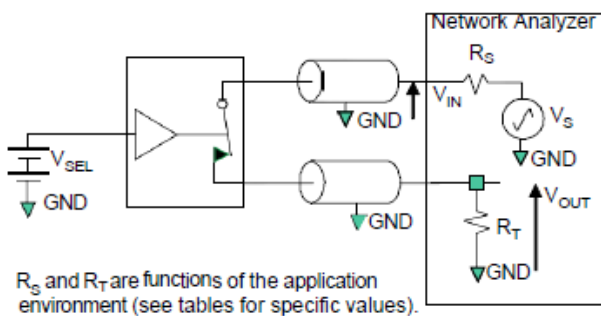


Figure 16. Bandwidth

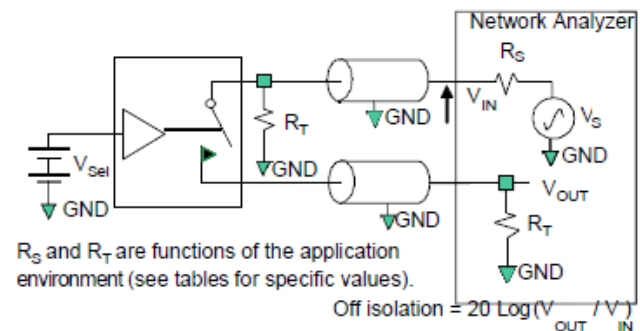


Figure 17. Channel Off Isolation

Test Diagrams /Timing Diagrams

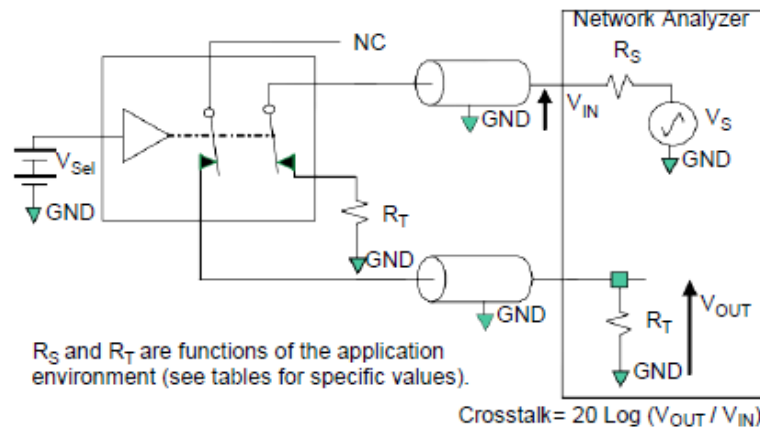


Figure 18. Non-Adjacent Channel-to-Channel Crosstalk

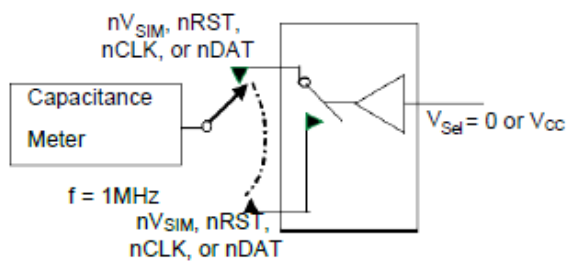


Figure 19. Channel Off Capacitance

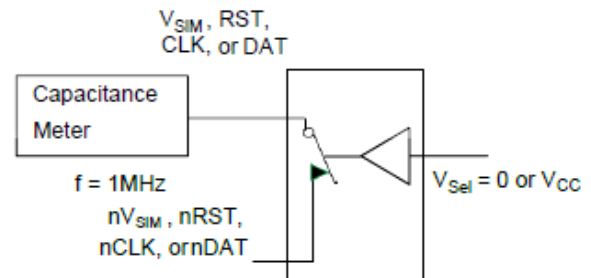
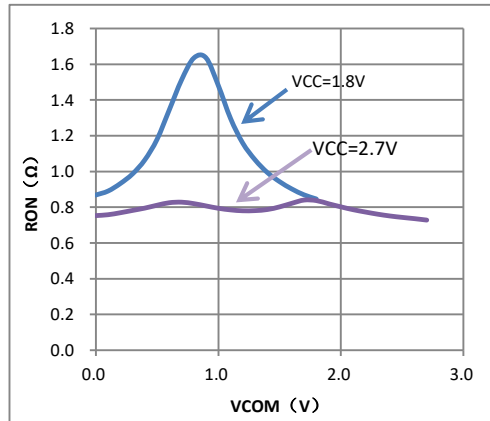


Figure 20. Channel On Capacitance

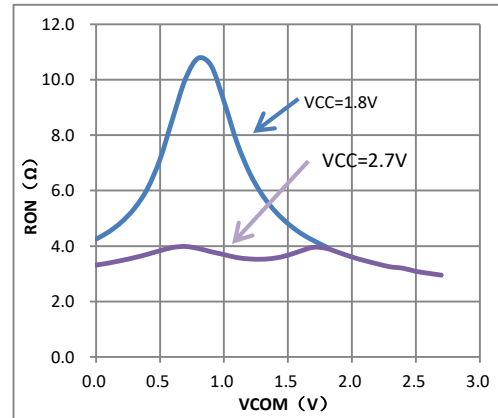
Typical Operating Characteristics

(VCC = 3V, TA = +25°C, unless otherwise noted.)

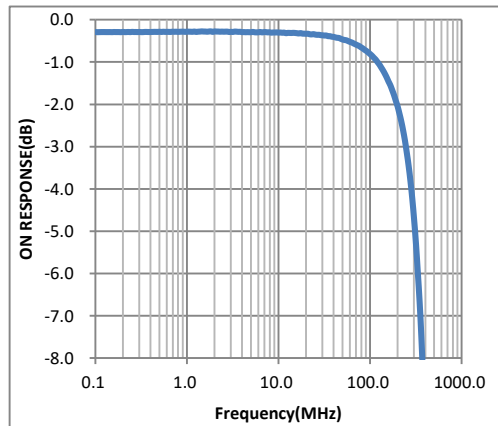
SUPPLY PATH ON-RESISTANCE



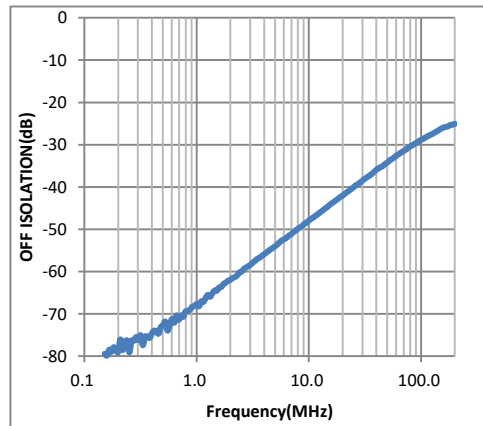
DATA PATH ON-RESISTANCE



ON-RESPONSE vs. FREQUENCY

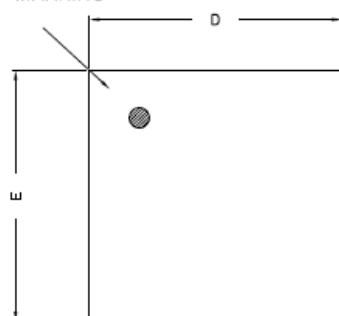


OFF-ISOLATION vs. FREQUENCY



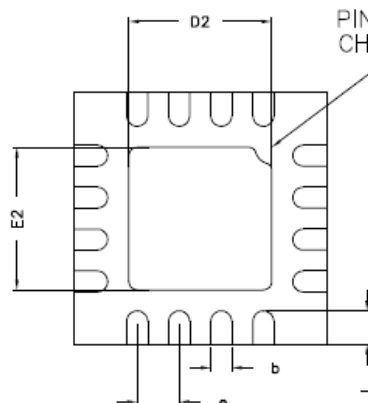
PACKAGE OUTLINE DIMENSIONS: TQFN 3x3 -16L

PIN 1 DOT
BY MARKING

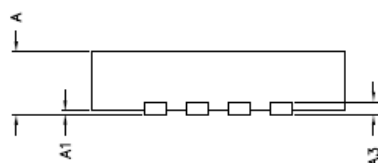


TOP VIEW

PIN #1 IDENTIFICATION
CHAMFER



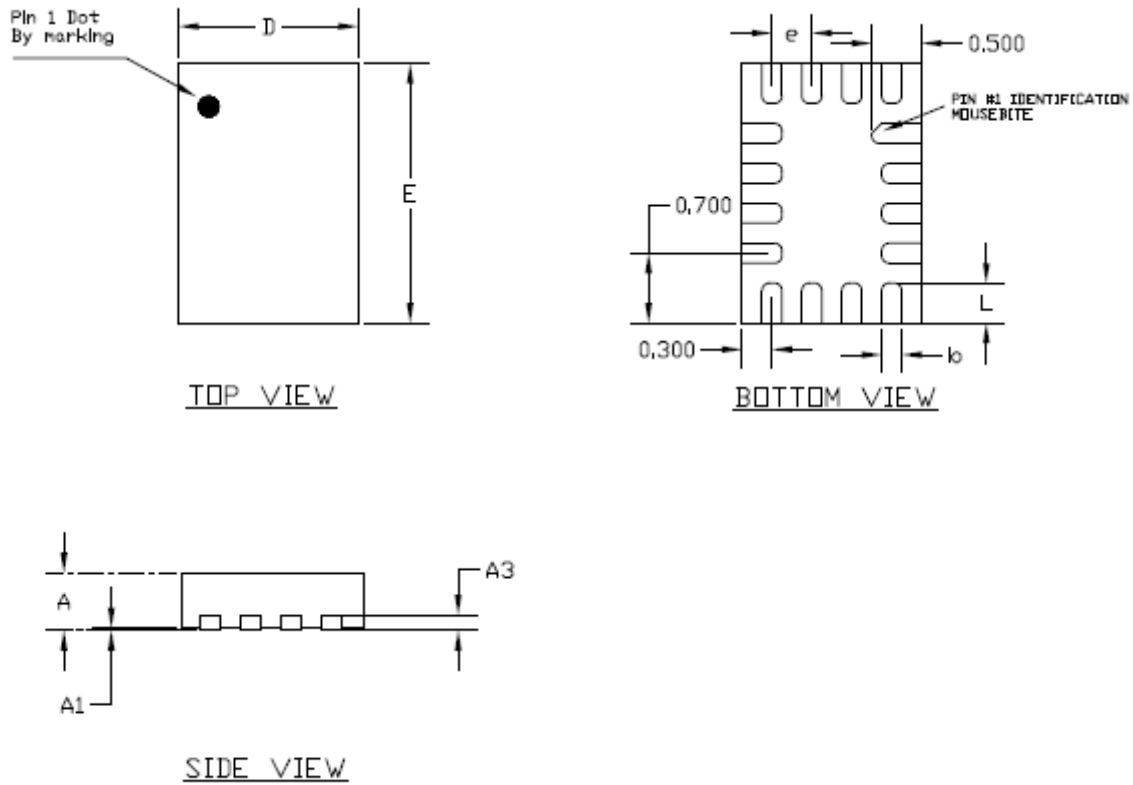
BOTTOM VIEW



SIDE VIEW

COMMON DIMENSIONS(MM)			
PKG.	W: VERY VERY THIN		
REF.	MIN.	NOM.	MAX
A	0.70	0.75	0.80
A1	0.00	—	0.05
A3	0.2 REF.		
D	2.95	3.00	3.05
E	2.95	3.00	3.05
b	0.18	0.25	0.30
L	0.30	0.40	0.50
D2	1.55	1.70	1.80
E2	1.55	1.70	1.80
e	0.5 BSC		

PACKAGE OUTLINE DIMENSIONS: QFN 2.6x1.8 -16L



COMMON DIMENSIONS(MM)			
PKG.	UT:ULTRA THIN		
REF.	MIN.	NOM.	MAX
A	>0.50	0.55	0.60
A1	0.00	-	0.05
A3	0.15 REF.		
D	1.75	1.80	1.85
E	2.55	2.60	2.65
L	0.30	0.40	0.50
b	0.15	0.20	0.25
e	0.40 BSC		